

Test report No.: 10312699S-C

Page : 1 of 27 Issued date : June 24

: June 24, 2014

Revised date FCC ID

: July 24, 2014 : BBP-RFTAU02

RADIO TEST REPORT

Test Report No.: 10312699S-C

Applicant

Ricoh Company, Ltd.

Type of Equipment

Multi-Function Printer

Model No.

Pro C7110SX

FCC ID

BBP-RFTAU02

Test regulation

FCC Part15 Subpart C: 2014

Test result

Complied

- 1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the limits of the above regulation.
- 4. The test results in this test report are traceable to the national or international standards.
- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by any agency of the Federal Government.
- 6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.

Date of test:

May 9 to 23, 2014

Tested by:

Makoto Hosaka

Engineer

Consumer Technology Division

Approved by:

Ichiro Isozaki

Leader

Consumer Technology Division





The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

UL Japan, Inc.

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Test report No.: 10312699S-C Page : 2 of 27 Issued date : June 24, 2014 Revised date : July 24, 2014

FCC ID : BBP-RFTAU02

REVISION HISTORY

Original Test Report No.: 10312699S-C

Revision	Test report No.	Date	Page revised	Contents
- (Original)	10312699S-C	June 24, 2014	-	-
1	10312699S-C	July 2, 2014	4, 19-23	P4: Update of Rating, Country of Mass-production
		, , ,	,	P19-23: Correction of typo
2	10312699S-C	July 18, 2014	4, 6	P4: Update of Variation of the family model(s)
				P6: Update of Frequency list
3	10312699S-C	July 24, 2014	11, 19	P11: Correction of the tables:
		-		Description of EUT, Auxiliary equipment
				P19: Update of data

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Test report No.: 10312699S-C
Page: 3 of 27
Issued date

Issued date : June 24, 2014 FCC ID : BBP-RFTAU02

Contents

	Page
SECTION 1: Customer information	4
SECTION 2: Equipment under test (E.U.T.)	4
SECTION 3: Test specification, procedures & results	7
SECTION 4: Operation of E.U.T. during testing	9
SECTION 5: Conducted emission	12
SECTION 6: Radiated emission (Fundamental and Spurious emission)	13
SECTION 7: 20dB bandwidth & Occupied bandwidth (99%)	14
SECTION 8: Frequency tolerances	15
Contents of APPENDIXES	16
APPENDIX 1: Data of radio tests	17
APPENDIX 2: Test instruments	25
APPENDIX 3: Photographs of test setup	

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No. : 10312699S-C Page : 4 of 27 Issued date : June 24, 2014 Revised date : July 18, 2014 FCC ID : BBP-RFTAU02

SECTION 1: Customer information

Company Name : Ricoh Company, Ltd.

Brand Name : RICOH

Address : 810 Shimoimaizumi, Ebina-shi, Kanagawa, 243-0460 Japan

Telephone Number : +81-50-3814-5604 Facsimile Number : +81-3-6893-1409 Contact Person : Hiroyuki Kuroda

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Multi-Function Printer

Model Number : Pro C7110SX
Serial Number : Refer to clause 4.2
Rating : AC208-240V, 50/ 60Hz

Country of Mass-production : U.S.A., Japan Condition of EUT : Production prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Receipt Date of Sample : May 7, 2014

Modification of EUT : No modification by the test lab.

2.2 Variation of the family model(s)

- Pro C7110SX (Tested model)

- Pro C7100SX

- Pro C7110X

- Pro C7100X

The difference of these models is as follows.

Model	Scanner Unit (Scanner & Copy Function)	Copy Speed	Print Speed
Pro C7100SX	Equipped	80 ppm	80 ppm
Pro C7110SX	Equipped	90 ppm	90 ppm
Pro C7100X	Not Equipped	None	80 ppm
Pro C7110X	Not Equipped	None	90 ppm

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 5 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

2.3 Product description

Model: Pro C7110SX (referred to as the EUT in this report) is a Multi-Function Printer.

The EUT is the color digital copy machine with high speed and high endurance, which is available also for a printer and a scanner.

General Features

- 1. The machine fits seemliness into high volume production environments with its optimum reliability, sophisticated finishing and professional software solutions.
- 2. The machine employs advanced 4 or 5-tandem drums system and image transfer belt technology to ensure dependability in even the most demanding environments.
- 3. The machine offers the choice of a number of finishing options including stapling, booklet making and online punching.
- 4. Scan- to-email and Scan-to-folder allow efficient distribution of scanned files and documents.

<Radio part>

Radio Type : Transceiver
Frequency of Operation : 13.56MHz
Modulation : ASK 100%
Power Supply (inner) : DC 5.0V

Antenna type : Print pattern antenna

ITU code : A1D

Operating Temperature : +10 to +32 deg C.

FCC 15.31 (e)

Host device provides the radio block with stable power supply, and the power is not changed when voltage of the printer is varied. Therefore, this EUT complies with the requirement.

FCC 15.203

The antenna is not removable from the EUT. Therefore, the equipment complies with the requirement.

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No. : 10312699S-C Page : 6 of 27

Issued date : June 24, 2014
Revised date : July 18, 2014
FCC ID : BBP-RFTAU02

The clock frequency used in EUT:

Highest Frequency:

Kind of equipment	Model name	Operates Frequency	Remarks
Multi-function Printer	Pro C7110SX	3000MHz	HDD I/F

Frequency list:

Derived Frequency	Description of Use	Remarks
1860.00MHz	Controller CPU	
800.00MHz	Controller DDR3	
2500.00MHz	PCI-Express	
480.00MHz	Controller USB-Host	
14.32MHz	Controller PCH	
33.30MHz	PCI	
133.30MHz	Controller ASIC	
3000.00MHz	HDD I/F	
50.00MHz	Controller SD_I/F	
1500.00MHz	Controller NAND	
480.00MHz	Controller USB_Device	
125.00MHz	Controller GigaEther	
192MHz	Engine Controller CPU	
132.71MHz	Engine Controller ASIC	
13.56MHz	RFID CPU	
31.25MHz	Operation Panel NAND FLASH	
34.60MHz	Operation Panel LCD CLK	
200.00MHz	Operation Panel DDR3	
800.00MHz	Operation Panel CPU Core	
48.00MHz	Operation Panel SD Card Clock	
240.00MHz	Operation Panel USB Clock	
8.00MHz	Operation Panel Microcomputer	
90.00MHz	Image Controller ASIC	
200MHz	Image Controller ASIC	
33.33MHz	Image Controller ASIC	
375MHz	SerDES	
533.33MHz	Image Controller DDR3	
26.453MHz	CCD CLK	
16.00MHz	CIS CLK	
60.00MHz	LVDS CLK	
45.9375MHz	LVDS CLK	
29.4912MHz	ADF Controller CPU	
265.4208MHz	ADF Controller ASIC	
1061.6832MHz	ADF Controller ASIC	
20MHz	LD Controller Microcomputer	
25MHz	LD Controller ASIC	
56.43MHz	LD Controller CLK	
96MHz	Media Identification CPU	
48MHz	Media Identification USB	

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 7 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2014,

final revised on May 1, 2014 and effective June 2, 2014

Title FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.209 Radiated emission limits, general requirements

Section 15.215 Additional provisions to the general radiated emission limitations

Section 15.225 Operation within the band 13.110-14.010MHz

The EUT complies with FCC Part 15 Subpart B. Refer to the test report: 10312699S-B.

3.2 Procedures & Results

Item	Test Procedure	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.4:2009 7. AC powerline conducted emission measurements	FCC 15.207	1	N/A	6.4dB Freq.: 0.19960MHz Detector: Quasi-Peak Phase: N Line: Main	Complied
Electric field strength of Fundamental emission	ANSI C63.4:2009 13. Measurement of intentional radiators	FCC 15.225 (a)	Radiated	N/A	70.6dB Polarization: Vertical	Complied
Electric field strength of Spurious emission (within the 13.110-14.010MHz band)	ANSI C63.4:2009 13. Measurement of intentional radiators	FCC 15.225 (b)(c)	Radiated	N/A	45.6dB Freq.: 13.110MHz Polarization: Vertical	Complied
Electric field strength of Spurious emission (outside of the 13.110-14.010MHz band)	ANSI C63.4:2009 13. Measurement of intentional radiators	FCC 15.209 FCC 15.225 (d)	Radiated	N/A	3.8dB Freq.: 625.02MHz Polarization: Vertical	Complied
20dB bandwidth	ANSI C63.4:2009 13. Measurement of intentional radiators	FCC 15.215 (c)	Radiated	N/A	-	-
Frequency tolerance Note: UL Japan's Wor	ANSI C63.4:2009 13. Measurement of intentional radiators	, ,	Radiated	N/A	-	Complied

3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results
Occupied Bandwidth (99%)	ANSI C63.4:2009 13. Measurement of intentional radiators, RSS-Gen 4.6.1	RSS-Gen 4.6.1	Radiated	-	-

^{*} Other than above, no addition, exclusion nor deviation has been made from the standard.

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^{*} The revision on May 1, 2014 does not affect the test specification applied to the EUT.

Test report No.: 10312699S-C Page: 8 of 27

Issued date : June 24, 2014 FCC ID : BBP-RFTAU02

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC*1/SR*2 (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) AMN/LISN	150kHz-30MHz	3.6 dB	3.6 dB	3.5 dB
Radiated emission	9kHz-30MHz	3.7 dB	3.7 dB	3.6 dB
(Measurement distance: 3m)	30MHz-300MHz	4.9 dB	5.1 dB	4.9 dB
	300MHz-1GHz	5.0 dB	5.2 dB	4.9 dB

^{*1:} SAC=Semi-Anechoic Chamber

Conducted emission test

The data listed in this test report has enough margin, more than site margin.

Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Frequency tolerance

Frequency (Normal condition) Measurement uncertainty for this test was: (\pm) 7.9 x 10^-8. Frequency (Extreme condition) Measurement uncertainty for this test was: (\pm) 7.9 x 10^-8.

Other tests

Bandwidth Measurement uncertainty for this test was: (±) 5.4%

3.5 Test location

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Telephone number : +81 463 50 6400 Facsimile number : +81 463 50 6401 JAB Accreditation No. : RTL02610

	FCC Registration No.	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measuremen t distance
No.1 Semi-anechoic chamber	697847	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
No.2 Semi-anechoic chamber	697847	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
☐ No.3 Semi-anechoic chamber	697847	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
No.4 Semi-anechoic chamber	-	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
☐ No.1 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
☐ No.2 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
☐ No.3 shielded room	-	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
☐ No.4 shielded room	-	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
☐ No.6 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.1 Measurement room	-	-	2.55 x 4.1 x 2.5	-	-

3.6 Test setup, Data of test & Test instruments

Refer to APPENDIX 1 to 3.

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^{*2:} SR= Shielded Room is applied besides radiated emission

Test report No.: 10312699S-C Page: 9 of 27 Issued date: June 24, 2014 FCC ID: BBP-RFTAU02

SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test item	Operating mode	Tested frequency
All items	Transmitting (ASK), 26byte	13.56MHz
except for	Mirror modulation from lower bit -> AM modulation	
Frequency	0x00, 0x00, 0xB3, 0x75, 0xB0, 0x00, 0x00, 0x80, 0x01, 0xff, 0xfe, 0x01, 0x23,	
tolerances	0x45, 0x67, 0x0B, 0x00, 0x00, 0x00, 0x00, 0x00, 0x00, 0x00, 0x00, 0x00, CRC, CRC	
Frequency	Transmitting Unmodulated	13.56MHz
tolerances		

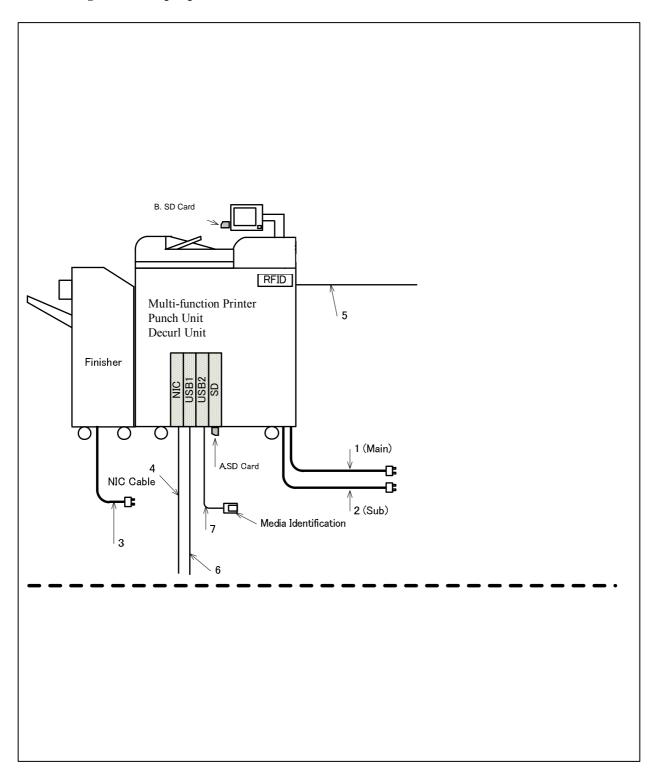
Software for testing: D1945405 Ver. 0.43:05

Justification: The system was configured in typical fashion (as customer would normally use it) for testing.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 10 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

4.2 Configuration and peripherals



^{*} Cabling and setup were taken into consideration and test data was taken under worse case conditions.

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 11 of 27
Issued date: June 24, 2014
Revised date: July 24, 2014
FCC ID: BBP-RFTAU02

Description of EUT

Kind of	Manufacture /	Model name	Serial number	Remarks
equipment	Code			
Multi-function	RICOH/D204-57	Pro C7110SX	V0000000001	AC240V/60Hz
Printer				

^{*} RFID module is installed in the Multi-function Printer.

Auxiliary equipment

Item	Kind of	Manufacturer	Model name	Serial number	Remarks
	equipment				
-	Finisher	RICOH	Booklet Finisher SR5060	E844E420033	AC120V/60Hz
		(Code: D734-17)			
-	Punch Unit	RICOH	Punch Unit PU5020 NA	2703126	for SR5060
		(Code: D449-17)			
-	Media	RICOH	Media Identification Unit	MOS000001	_
	Identification	(Code: D3AK-00)	Type S3		
-	Decurl Unit	RICOH	Decurl Unit DU5040	G404F400002	_
		(Code: D3A4-17)			
A	SD Card	Transcend	TA512MSD80	436271057	To Color Copier
В	SD Card	Panasonic	RP-SD256BJ1A	SU6HC073298	To Color Copier

List of cables used

List of	cables useu					
Item	Cable Name	Manufacturer	Length	Shielding	Connector	Remarks
			(m)	(Cable)		
1	Power Cable	RICOH	4.0	No	Plastic	AC240V/60Hz
						Lower side of the
						machine
2	Power Cable	RICOH	4.0	No	Plastic	AC240V/60Hz
						Upper side of the machine
3	Power Cable	RICOH	2.5	No	Plastic	AC120V/60Hz
4	NIC Cable	-	3.0	No	Plastic	
5	External Controller Cable1	RICOH	12.0	Yes	Metal	
6	External Controller Cable2	RICOH	5.0	Yes	Metal	
7	USB (Media Identification)	RICOH	1.5	Yes	Metal	

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 12 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

SECTION 5: Conducted emission

5.1 Operating environment

The test was carried out in a semi-anechoic chamber.

Temperature: Refer to APPENDIX 1. Humidity: Refer to APPENDIX 1.

5.2 Test configuration

EUT was placed on a carpet for insulation above the ground plane. EUT was set up typical spacing for the other equipment. EUT was located 80cm from LISN and excess AC cable was bundled in center. I/O cables that were connected to the peripherals were bundled in center. I/O cables that were connected to the peripherals were bundled in center. They were folded back and for the forming a bundle 30cm to 40cm long.

Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN to the input power source. All unused 50Ω connectors of the LISN were resistively terminated in 50Ω when not connected to the measuring equipment.

Photographs of the set up are shown in Appendix 3.

5.3 Test conditions

Frequency range : 0.15 - 30MHz EUT position : Floor standing

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a semi-anechoic chamber. The EUT was connected to a Line Impedance Stabilization Network (LISN).

An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, a CISPR average detector.

The conducted emission measurements were made with the following detection of the test receiver.

Detection Type : Quasi-Peak/ CISPR-Average

IF Bandwidth : 9kHz

5.5 Results

Summary of the test results: Pass

Refer to APPENDIX 1.

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 13 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

SECTION 6: Radiated emission (Fundamental and Spurious emission)

6.1 Operating environment

The test was carried out in a semi-anechoic chamber.

Temperature: Refer to APPENDIX 1. Humidity: Refer to APPENDIX 1.

6.2 Test configuration

EUT was placed on a carpet for insulation above the ground plane. EUT was set up typical spacing for the other equipment. Photographs of the set up are shown in Appendix 3.

6.3 Test conditions

Frequency range : 9kHz - 1GHz

Test distance : 3m

EUT position : Floor standing

6.4 Test procedure

The Radiated Electric Field Strength intensity has been measured with a ground plane and at a distance of 3m Frequency: From 9kHz to 30MHz at distance 3m

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for vertical polarization (antenna angle: 0deg.to 360deg.) and horizontal polarization. Drawing of the antenna direction is shown in Figure 1.

Frequency: From 30MHz to 1GHz at distance 3m (Refer to Figure 2).

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Measurements were performed with QP, PK, and AV detector.

The radiated emission measurements were made with the following detector function of the test receiver.

	9kHz to 90kHz &	90kHz to	150kHz	490kHz to	30MHz to 1GHz
	110kHz to 150kHz	110kHz	to 490kHz	30MHz	
Detector Type	PK/AV	QP	PK/AV	QP	QP
IF Bandwidth	200Hz	200Hz	9kHz	9kHz	120kHz
Measuring		Loop anter	nna		Biconical (30-299.99MHz)
antenna					Logperiodic (300MHz-1GHz)

^{*} FCC 15.31 (f)(2) (9kHz-30MHz)

9kHz – 490kHz [Limit at 3m]= [Limit at 300m]-40log (3[m]/300[m])

490kHz - 30MHz [Limit at 3m]= [Limit at 30m]-40log (3[m]/30[m])

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

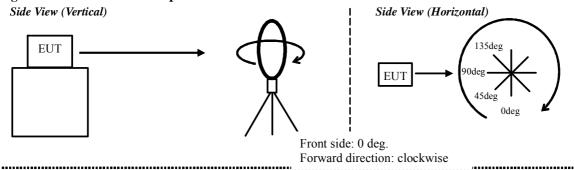
Test report No.: 10312699S-C
Page: 14 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

6.5 Results

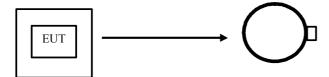
Summary of the test results: Pass

Refer to APPENDIX 1.

Figure 1. Direction of the Loop Antenna

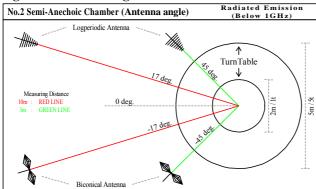


Top View (Horizontal)



Antenna was not rotated.

Figure 2. Antenna angle



SECTION 7: 20dB bandwidth & Occupied bandwidth (99%)

Test procedure

The test was measured with a spectrum analyzer using a test fixture.

Results

Summary of the test results: Pass

Refer to APPENDIX 1.

UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 15 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

SECTION 8: Frequency tolerances

Test procedure

The test was measured with a spectrum analyzer using a test fixture.

The temperature test was started after the temperature stabilization time of 30 minutes.

The test was begun from 50 deg.C and the temperature was lowered each 10 deg.C.

Results

Summary of the test results: Pass

Refer to APPENDIX 1.

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Test report No.: 10312699S-C
Page: 16 of 27
Issued date: June 24, 2014
FCC ID: BBP-RFTAU02

Contents of APPENDIXES

APPENDIX 1: Data of Radio tests

Conducted emission Radiated emission Frequency tolerance Bandwidth

APPENDIX 2: Test instruments

Test instruments

APPENDIX 3: Photographs of test setup

Conducted emission Radiated emission

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber

Date: 2014/05/23

RICOH COMPANY, LTD Company Kind of EUT Multi Function Printer Model No. Pro C7110SX V000000001 Serial No.

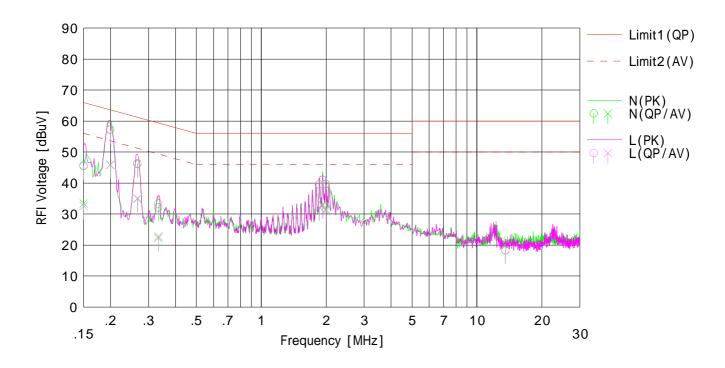
Main

Transmitting 10312699S Mode Order No. AC240V/60Hz 22deg.C/55%RH Power Temp./Humi.

Limit1 : FCC 15C(15.207) QP Limit2 : FCC 15C(15.207) AV

Remarks

Engineer : Makoto Hosaka



	F	Rea	ding	0.5	Res	ults	Lin	nit	Mar	gin		
No.	Freq.	<qp></qp>	<av></av>	C.Fac	<qp></qp>	<av></av>	<qp></qp>	<av></av>	<qp></qp>	<av></av>	Phase	Comment
	[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
1	0.15000	31.5	19.5	13.9	45.4	33.4	66.0	56.0	20.6	22.6	N	
2	0.19960	44.3	32.9	12.9	57.2	45.8	63.6	53.6	6.4	7.8	N	
3	0.26700	33.3	22.1	12.9	46.2	35.0	61.2	51.2	15.0	16.2	N	
4	0.33320	19.3	9.5	12.8	32.1	22.3	59.3	49.3	27.2	27.0	N	
5	1.85862	26.6	19.3	12.9	39.5	32.2	56.0	46.0	16.5	13.8	N	
6	1.92588	28.2	20.1	12.9	41.1	33.0	56.0	46.0	14.9	13.0	N	
7	1.99230	26.8	18.5	12.9	39.7	31.4	56.0	46.0	16.3	14.6	N	
8	13.56000	4.6		13.7	18.3		60.0	50.0	41.7		N	
9	0.15000	31.8	18.7	13.9	45.7	32.6	66.0	56.0	20.3	23.4	L	
10	0.19960	44.2	33.0	12.9	57.1	45.9	63.6	53.6	6.5	7.7	L	
11	0.26700	33.4	22.0	12.9	46.3	34.9	61.2	51.2	14.9	16.3	L	
12	0.33320	20.5	10.0	12.8	33.3	22.8	59.3	49.3	26.0	26.5	L	
13	1.85862	26.6	19.3	12.9	39.5	32.2	56.0	46.0	16.5	13.8	L	
14	1.92588	28.0	19.8	12.9	40.9	32.7	56.0	46.0	15.1	13.3	L	
15	1.99230	26.6	18.1	12.9	39.5	31.0	56.0	46.0	16.5	15.0	L	
16	13.56000	4.7		13.7	18.4		60.0	50.0	41.6		L	

17 of 27

DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber

Date: 2014/05/23

RICOH COMPANY, LTD Company Kind of EUT Multi Function Printer Model No. Pro C7110SX Serial No.

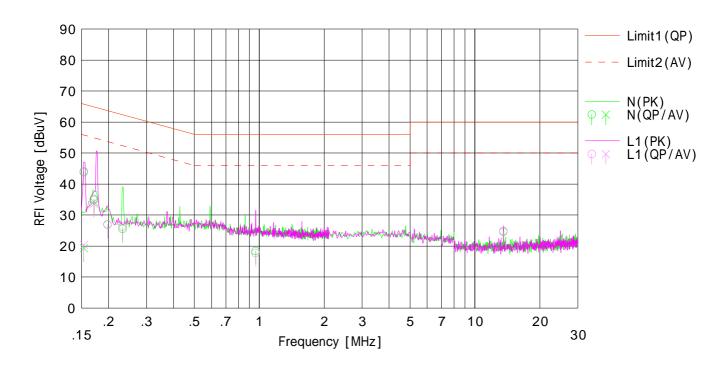
V000000001

Remarks Sub

Transmitting 10312699S Mode Order No. AC240V/60Hz 22deg.C/55%RH Power Temp./Humi.

Limit1 : FCC 15C(15.207) QP Limit2 : FCC 15C(15.207) AV

Engineer : Makoto Hosaka



	F	Rea	ding	0.5	Res	ults	Lin	nit	Mar	rgin		
No.	Freq.	<qp></qp>	<av></av>	C.Fac	<qp></qp>	<av></av>	<qp></qp>	<av></av>	<qp></qp>	<av></av>	Phase	Comment
	[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
1	0.15370	30.0	5.5	13.8	43.8	19.3	65.7	55.7	21.9	36.4	N	
2	0.17133	21.6	20.7	13.5	35.1	34.2	64.8	54.8	29.7	20.6	N	
3	0.19820	14.0		12.9	26.9		63.6	53.6	36.7		N	
4	0.23261	12.6		12.9	25.5		62.3	52.3	36.8		N	
5	0.96330	5.6		12.8	18.4		56.0	46.0	37.6		N	
6	13.56000	10.9		13.7	24.6		60.0	50.0	35.4		N	
7	0.15370	30.3	6.5	13.8	44.1	20.3	65.7	55.7	21.6	35.4	L1	
8	0.17133	21.3	20.1	13.5		33.6	64.8	54.8	30.0	21.2	L1	
9	0.19820	14.1		12.9	27.0		63.6	53.6	36.6		L1	
10	0.23261	13.4		12.9	26.3		62.3	52.3	36.0		L1	
11	0.96330	5.0		12.8	17.8		56.0	46.0	38.2		L1	
12	13.56000	11.1		13.7	24.8		60.0	50.0	35.2		L1	

<u>Data of Electric field strength of Fundamental emission</u> and Spurious emission within the band: FCC15.225(a)(b)(c)

UL Japan, Inc.

Shonan EMC Lab., No.2 Semi-Anechoic Chamber

Company: RICOH COMPANY, LTD Regulation: FCC Part15 SubpartC 15.225

Equipment: Multi Function Printer Test Distance: 3m

Model: Pro C7110SX Date: May 10, 2014 V000000001 22 deg.C Sample No.: Temperature: Power: AC240V/60Hz Humidity: 42 %RH ENGINEER: Mode: Transmitting 13.56MHz Tatsuya Arai

Remarks: : Vertical polarization (antenna angle) of the worst case: Odeg

Fundamental emission

No.	FREQ	Test R	eceiver	Antenna	LOSS	AMP	Distance	RESULT		LIMIT	MAI	RGIN
		Rea	ding	Factor		GAIN	factor			(30m)		
		Hor	Ver					Hor	Ver		Hor	Ver
	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]
1	13.560	58.1	59.8	19.0	6.4	31.9	-40.0	11.6	13.3	83.9	72.3	70.6

 $Calculation: Result[dBuV/m] = Reading[dBuV] + Ant. Fac[dB/m] + Loss(Cable + ATT)[dB] - Gain(AMP)[dB] + Distance\ factor[dB] + Calculation: Result[dBuV/m] + Calculation: Result[dBuV/m]$

Distance factor: $40 \times \log (3m/30m) = -40 \text{ dB}$

Limits (30m)

·13.553MHz to 13.567MHz: 83.9dBuV/m (FCC 15.225(a))

*worst carrier and spurious level @ 3m

	Hor	Ver
carrier	51.6	53.3
spurious	39.2	42.2

[dBuV/m]

Spurious emission within the band

No.	FREQ	Test R	eceiver	Antenna	LOSS	AMP	Distance	RES	ULT	LIMIT	MAI	RGIN
		Rea	ding	Factor		GAIN	factor			(30m)		
		Hor	Ver					Hor	Ver		Hor	Ver
	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]
1	13.110	30.2	30.3	19.1	6.4	31.9	-40.0	-16.2	-16.1	29.5	45.7	45.6
2	13.410	30.3	30.3	19.0	6.4	31.9	-40.0	-16.2	-16.2	40.5	56.7	56.7
3	13.553	44.2	45.7	19.0	6.4	31.9	-40.0	-2.3	-0.8	50.4	52.7	51.2
4	13.567	43.8	45.1	19.0	6.4	31.9	-40.0	-2.7	-1.4	50.4	53.1	51.8
5	13.710	30.3	30.3	19.0	6.4	31.9	-40.0	-16.2	-16.2	40.5	56.7	56.7
6	14.010	30.3	30.3	18.9	6.5	31.9	-40.0	-16.2	-16.2	29.5	45.7	45.7

 $Calculation: Result[dBuV/m] = Reading[dBuV] + Ant. Fac[dB/m] + Loss(Cable + ATT)[dB] - Gain(AMP)[dB] + Distance\ factor[dB] + Calculation: Result[dBuV/m] + Calculation + Calculation$

Outside filed strength frequencies

- ·Fc±7kHz:13.553MHz to 13.567MHz
- •Fc±150kHz:13.410MHz to 13.710MHz
- •Fc±450kHz:13.110MHz to 14.010MHz

Fc = 13.56MHz

Limits (30m)

- ·13.410MHz to 13.553MHz and 13.567MHz to 13.710MHz : 50.4dBuV/m (FCC 15.225(b))
- $\cdot 13.110 MHz \ to \ 13.410 MHz \ and \ 13.710 MHz \ to \ 14.010 MHz : 40.5 dBuV/m \ \ (FCC \ 15.225(c))$
- ·Below 13.110MHz and Above 14.010MHz: 29.5dBuV/m (FCC 15.225(d)and FCC 15.209)

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Radiated Emission

UL Japan, Inc.

Shonan EMC Lab. No.2 Semi Anechoic Chamber

Company: RICOH COMPANY, LTD Regulation: FCC Part15 SubpartC 15.225

Equipment: Multi Function Printer Test Distance 3m

 Model:
 Pro C7110SX
 Date:
 May 10, 2014

 Sample No.:
 V0000000001
 Temperature: 22 deg. C

 Power:
 AC240V/60Hz
 Humidity:
 42 %RH

 Mode:
 Transmitting 13.56MHz
 ENGINEER: Tatsuya Arai

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg.]	
Hori.	27.12	QP	30.3	19.8	-33.3	31.9	-15.1	29.5	44.6	-		Limit: 30m
Hori.	40.68	QP	30.3	14.1	7.0	31.9	19.5	40.0	20.5	262	359	Limit: 3m
Hori.	54.24	QP	27.2	9.4	7.2	31.9	11.9	40.0	28.1	349	8	
Hori.	67.80	QP	33.2	6.7	7.1	31.9	15.1	40.0	24.9	293	285	
Hori.	81.36	QP	34.0	6.6	8.0	31.9	16.7	40.0	23.3	249	282	
Hori.	94.92	QP	33.9	9.2	8.0	31.9	19.2	43.5	24.3	339	294	
Hori.	106.28	QP	48.5	11.1	7.9	31.9	35.6	43.5	7.9	305	275	
Hori.	108.48	QP	30.4	11.4	7.9	31.9	17.8	43.5	25.7	170	12	
Hori.	122.04	QP	33.1	13.2	7.9	31.9	22.3	43.5	21.2	372	81	
Hori.	135.60	QP	31.0	14.2	8.2	31.8	21.6	43.5	21.9	244	221	
Hori.	412.47	QP	44.5	16.3	7.2	31.7	36.3	46.0	9.7	100	166	
Hori.	625.01	QP	39.7	19.3	8.3	31.7	35.6	46.0	10.4	126	107	
Hori.	875.02	QP	38.9	21.9	9.4	31.0	39.2	46.0	6.8	176	174	
Vert.	27.12	QP	30.5	19.8	-33.3	31.9	-14.9	29.5	44.4	-	68	Limit: 30m
Vert.	40.68	QP	32.2	14.1	7.0	31.9	21.4	40.0	18.6	100	254	Limit: 3m
Vert.	54.24	QP	34.2	9.4	7.2	31.9	18.9	40.0	21.1	100	332	
Vert.	67.80	QP	35.6	6.7	7.1	31.9	17.5	40.0	22.5	100	3	
Vert.	81.36	QP	37.9	6.6	8.0	31.9	20.6	40.0	19.4	100	23	
Vert.	94.92	QP	40.9	9.2	8.0	31.9	26.2	43.5	17.3	100	348	
Vert.	106.28	QP	47.9	11.1	7.9	31.9	35.0	43.5	8.5	100	106	
Vert.	108.48	QP	34.0	11.4	7.9	31.9	21.4	43.5	22.1	100	352	
Vert.	122.04	QP	37.1	13.2	7.9	31.9	26.3	43.5	17.2	100	147	
Vert.	135.60	QP	34.1	14.2	8.2	31.8	24.7	43.5	18.8	100	131	
Vert.	412.46	QP	44.8	16.3	7.2	31.7	36.6	46.0	9.4	124	19	
Vert.	625.02	QP	46.3	19.3	8.3	31.7	42.2	46.0	3.8	114	129	
Vert.	875.02	QP	37.8	21.9	9.4	31.0	38.1	46.0	7.9	100	189	

Result (Below 30MHz) = Reading + Ant Factor + Loss (Cable+Attenuator+Distance factor) - Gain(Amprifier)

 $Result\ (Above\ 30MHz) = Reading + Ant\ Factor + Loss\ (Cable + Attenuator) - Gain(Amprifier)$

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^{*}Distance factor: $40 \times \log (3m/30m) = -40 \text{ dB}$

^{*}Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Data of Frequency Tolerance: FCC 15.225(e)

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company: RICOH COMPANY, LTD Regulation: FCC Part15 SubpartC 15.225

Equipment: Multi Function Printer

Model: Pro C7110SX Date: May 9, 2014 V000000001 25 deg.C Sample No.: Temperature: DC 5V (RFID Module) Humidity: 48 %RH Power: ENGINEER: Tatsuya Arai Mode: Transmitting 13.56MHz

Temperature Variation: 50deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
Test Collditions	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559909	-0.000091	-0.00067	0.01
after 2minutes	13.56	13.559910	-0.000090	-0.00066	0.01
after 5minutes	13.56	13.559909	-0.000091	-0.00067	0.01
after 10minutes	13.56	13.559909	-0.000091	-0.00067	0.01

Temperature Variation: 40deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
Test Collations	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559906	-0.000094	-0.00069	0.01
after 2minutes	13.56	13.559907	-0.000093	-0.00069	0.01
after 5minutes	13.56	13.559907	-0.000093	-0.00069	0.01
after 10minutes	13.56	13.559907	-0.000093	-0.00069	0.01

Temperature Variation: 30deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
Test Conditions	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559912	-0.000088	-0.00065	0.01
after 2minutes	13.56	13.559911	-0.000089	-0.00066	0.01
after 5minutes	13.56	13.559912	-0.000088	-0.00065	0.01
after 10minutes	13.56	13.559912	-0.000088	-0.00065	0.01

Temperature Variation: 20deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
Test Conditions	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559918	-0.000082	-0.00060	0.01
after 2minutes	13.56	13.559918	-0.000082	-0.00060	0.01
after 5minutes	13.56	13.559918	-0.000082	-0.00060	0.01
after 10minutes	13.56	13.559918	-0.000082	-0.00060	0.01

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Data of Frequency Tolerance: FCC 15.225(e)

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company: RICOH COMPANY, LTD Regulation: FCC Part15 SubpartC 15.225

Equipment: Multi Function Printer

Model: Pro C7110SX Date: May 9, 2014 25 deg.C V000000001 Sample No.: Temperature: 48 %RH Power: DC 5V (RFID Module) Humidity: Tatsuya Arai ENGINEER: Mode: Transmitting 13.56MHz

Temperature Variation: 10deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559914	-0.000086	-0.00063	0.01
after 2minutes	13.56	13.559915	-0.000085	-0.00063	0.01
after 5minutes	13.56	13.559916	-0.000084	-0.00062	0.01
after 10minutes	13.56	13.559915	-0.000085	-0.00063	0.01

Temperature Variation: 0deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559891	-0.000109	-0.00080	0.01
after 2minutes	13.56	13.559893	-0.000107	-0.00079	0.01
after 5minutes	13.56	13.559894	-0.000106	-0.00078	0.01
after 10minutes	13.56	13.559894	-0.000106	-0.00078	0.01

Temperature Variation: -10deg.C

Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit
Test Collditions	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559848	-0.000152	-0.00112	0.01
after 2minutes	13.56	13.559850	-0.000150	-0.00111	0.01
after 5minutes	13.56	13.559852	-0.000148	-0.00109	0.01
after 10minutes	13.56	13.559852	-0.000148	-0.00109	0.01

Temperature Variation: -20deg.C

Temperature - unation Tought						
Test Conditions	Original Frequency	Measured Frequency	Frequency Error	Frequency Tolerance	Limit	
	(MHz)	(MHz)	(MHz)	(%)	(%)	
startup	13.56	13.559761	-0.000239	-0.00176	0.01	
after 2minutes	13.56	13.559765	-0.000235	-0.00173	0.01	
after 5minutes	13.56	13.559768	-0.000232	-0.00171	0.01	
after 10minutes	13.56	13.559771	-0.000229	-0.00169	0.01	

Temperature Variation: -30deg.C

Test Conditions	Original Frequency	Measure Frequency	Frequency Error	Frequency Tolerance	Limit
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559654	-0.000346	-0.00255	0.01
after 2minutes	13.56	13.559661	-0.000339	-0.00250	0.01
after 5minutes	13.56	13.559661	-0.000339	-0.00250	0.01
after 10minutes	13.56	13.559661	-0.000339	-0.00250	0.01

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Data of Frequency Tolerance: FCC 15.225(e)

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company: RICOH COMPANY, LTD Regulation: FCC Part15 SubpartC 15.225

Equipment: Multi Function Printer

Model: Pro C7110SX Date: May 9, 2014 25 deg.C Sample No.: V0000000001 Temperature: 48 %RH Power: DC 5V (RFID Module) Humidity: ENGINEER: Mode: Transmitting 13.56MHz Tatsuya Arai

Input Voltage:DC4.25V (85%) <u>Temperature Variation: 20deg.C</u>

Original Frequency Measure Frequency Frequency Error Frequency Tolerance Limit Test Conditions (MHz) (MHz) (MHz) (%) (%) startup 13.56 13.559935 -0.000065 -0.00048 0.01 after 2minutes 13.56 13.559935 -0.000065 -0.00048 0.01 after 5minutes 13.56 13.559934 -0.000066 -0.00049 0.01 after 10minutes 13.56 13.559934 -0.000066 -0.00049 0.01

Input Voltage:DC5.75V (115%)

Temperature Variation: 20deg.C

Test Conditions	Original Frequency	Measure Frequency	Frequency Error	Frequency Tolerance	Limit
	(MHz)	(MHz)	(MHz)	(%)	(%)
startup	13.56	13.559935	-0.000065	-0.00048	0.01
after 2minutes	13.56	13.559934	-0.000066	-0.00049	0.01
after 5minutes	13.56	13.559934	-0.000066	-0.00049	0.01
after 10minutes	13.56	13.559933	-0.000067	-0.00049	0.01

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Test Report No: 10312699S-C

20dB bandwidth & 99% Occupied bandwidth: FCC 15.215 / RSS-Gen

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company: RICOH COMPANY, LTD

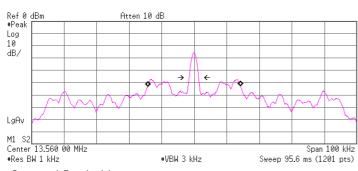
Equipment: Multi Function Printer

Model: Pro C7110SX
Sample No.: V0000000001
Power: DC 5V (RFID Module)
Mode: Transmitting 13.56MHz

Regulation: FCC Part15 Subpart C 15.215

Date: May 9, 2014
Temperature: 25 deg.C
Humidity: 48 % RH
ENGINEER: Tatsuya Arai

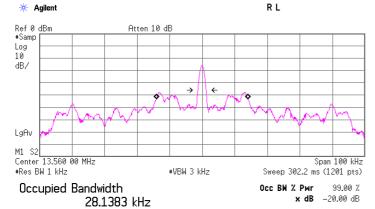
20dB Bandwidth: 2.982 kHz ** Agilent R L



Occupied Bandwidth 28.4878 kHz Occ BW % Pwr 99.00 % x dB -20.00 dB

Transmit Freq Error 18.144 Hz Occupied Bandwidth 2.982 kHz

99% Occupied Bandwidth: 28.138 kHz



Transmit Freq Error -11.742 Hz Occupied Bandwidth 2.592 kHz*

UL Japan, Inc. Shonan EMC Lab.

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Test Report No: 10312699S-C

APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SFC-01	Microwave Counter	Agilent	53151A	US40511493	FT	2014/04/01 * 12
SCH-01	Temperature and Humidity Chamber	Espec	PL-1KT	14020837	FT	2014/04/15 * 12
SSA-03	Spectrum Analyzer	Agilent	E4448A	MY48250152	BW	2014/02/03 * 12
SSCA-01	Search coil	LANGER	RF-R 400-1	02-0634	FT/BW	Pre Check
SOS-09	Humidity Indicator	A&D	AD-5681	4061484	FT/BW	2014/03/07 * 12
SAF-02	Pre Amplifier	SONOMA	310N	290212	RE	2014/02/17 * 12
SAT6-02	Attenuator	JFW	50HF-006N	-	RE	2014/02/17 * 12
KAT3-11	Attenuator	JFW IND. INC.	50HF-003N	-	RE	2013/08/19 * 12
SBA-02	Biconical Antenna	Schwarzbeck	BBA9106	91032665	RE	2013/11/24 * 12
SCC-B1/B3/B5 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906		RE	2014/04/25 * 12
SCC-B2/B4/B6 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-270(RF Selector)	RE	2014/04/25 * 12
SLA-02	Logperiodic Antenna	Schwarzbeck	UHALP9108A	UHALP 9108-A 0893	RE	2013/11/24 * 12
SOS-03	Humidity Indicator	A&D	AD-5681	4063325	RE/CE	2014/02/21 * 12
STR-07	Test Receiver	Rohde & Schwarz	ESU26	100484	RE/CE	2014/02/18 * 12
SJM-14	Measure	ASKUL	-	-	RE/CE	-
SAEC-02(NSA)	Semi-Anechoic Chamber	TDK	SAEC-02(NSA)	2	RE	2013/07/06 * 12
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE,CE, RFI,MF)	-	RE/CE	-
SLP-02	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100218	RE	2013/11/08 * 12
SAT6-07	Attenuator	JFW	50HF-006N	-	RE	2014/02/17 * 12
SCC-B9/B10/B 11/B13/SRSE- 02	Coaxial Cable&RF Selector	Suhner/Fujikura/Suhner /Suhner/TOYO	RG223U/12DSFA/ 141PE/NS4906	-/0901-270(RF Selector)	CE	2014/04/25 * 12
SLS-07	LISN	Schwarzbeck	NSLK8126	8126441	CE(EUT)	2014/05/16 * 12
SLS-06	LISN	Schwarzbeck	NSLK8126	8126440	CE(EUT)	2014/04/16 * 12
SLS-01	LISN	Rohde & Schwarz	ENV216	100511	CE	2014/02/14 * 12
SAT3-06	Attenuator	JFW	50HF-003N	-	CE	2014/02/17 * 12
STM-03	Terminator	TME	CT-01 BP	-	CE	2013/12/26 * 12
STM-04	Terminator	TME	CT-01 BP	-	CE	2013/12/26 * 12
SHF-02	Highpass Filter	Rohde & Schwarz	EZ-25	100022	CE	2014/03/11 * 12
SCC-02	Coaxial Cable	Fujikura	5D2W	_	CE	2014/01/07 * 12

The expiration date of the calibration is the end of the expired month . As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards.

Test Item:

CE: Conducted emission, RE: Radiated emission, BW: Bandwidth, FT: Frequency tolerance

25 of 27 UL Japan, Inc. Page: